

FORM PTO-1449
(MODIFIED)

SEP 22 2003

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

KCC-1162

SERIAL NO.

10/036,864

LIST OF PRIOR ART CITED BY APPLICANT
(Use several sheets if necessary)

APPLICANT(S)

Sridhar RANGANATHAN et al.

FILING DATE

21 December 2001

GROUP

1746

RECEIVED

SEP 23 2003

TC 1700

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
EE	AL	WO 99/63923	12/1999	PCT				
	AM	EP 1 029 886 A2	08/2000	Europe				
	AN	WO 00/69383	11/2000	PCT				
EE	AO	WO 02/077347 A2	10/2002	PCT				
	AP	WO 02/076520 A2	10/2002	PCT				

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EE	AR	Derwent Abstract; XP 002240906 & KR 8 901 835 B; 05/25/89
EE	AS	Patent Abstracts of Japan; 1/21/94 & JP 05 263318 A; 10/12/93
EE	AT	Bronkhorst et al.: Deformation and Failure Behavior of Paper, Handbook of Physical Testing of Paper, pp. 313-349, Volume 1, 2002

EXAMINER

Eligible MDE

DATE CONSIDERED

9/16/04

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

KCC-1162

USCOMM-DC 80-3985

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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

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10/036,842

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Sridhar RANGANATHAN et al.

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21 December 2001

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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
EE	AA	4,756,969	07/1988	Takeda			
	AB	5,246,770	09/1993	Bottiglione et al.			
	AC	5,418,045	05/1995	Pike et al.			
	AD	5,858,535	01/1999	Wang et al.			
EE	AE	6,214,274	04/2001	Melius et al.			
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
EE	AL	GB 2 196 343 A	04/1988	Great Britain				
	AM	EP 0 540 041 B1	05/1993	Europe				
	AN	WO 96/14885	05/1996	PCT				
	AO	WO 97/27884	08/1997	PCT				
EE	AP	WO 98/48857	11/1998	PCT				

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EE	AR	Cavlin et al.: A New Method for Measuring the Edgewise Compression Properties of Paper, Svensk Papperstidning, No. 9, pp. 330-332, 1975
EE	AS	Derwent Abstract; XP 002240776 & JP 58 019360 A; 02/04/83
EE	AT	Derwent Abstract; XP 002240768 & JP 61 055249 A; 03/19/86

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Elizabeth M. Olo

DATE CONSIDERED

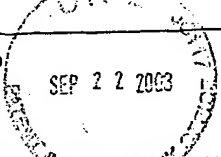
2/11/02

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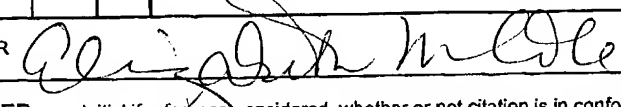

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FORM PTO-1449 (MODIFIED)				U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. KCC-1162		SERIAL NO. 10/036,864	
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						APPLICANT(S) Sridhar RANGANATHAN et al.			

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							YES	NO
	AL							
	AM							
	AN							
	AO							
	AP							

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)			
	AR		Fellers et al.: <u>Edgewise Compression Strength of Paper</u> , <u>Handbook of Physical Testing of Paper</u> , pp. 481-503, Volume 1, 2002
	AS		
	AT		

EXAMINER 	DATE CONSIDERED 
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